



JSC Teltonika

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## RELIABILITY PREDICTION REPORT

Equipment under test: LTE router RUT950  
Product: RUT950  
Manufacturer: Teltonika  
Report No.: TLTK-20160107RT95-50  
Report Date: 6 January, 2016

Documented by:

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Engineer

Approved by:

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## 1. PURPOSE

Reliability prediction methodology provides the basis for reliability evaluation and analysis. The purpose of the prediction is to predict the life time of the product in units of failure rate and MTBF.

## 2. RELIABILITY PREDICTION

### 2.1 Analysis database

MTBF Calculator by ALD

### 2.2 Analysis method

The prediction method used was Telcordia SR-332, Issue 2, Parts Count

Failure rate ( $\lambda$ ) =  $10^9$  hours (FITs)

MTBF =  $1/\lambda$

$$\lambda_{ssi} = \lambda_{Gi} \pi_{Qi} \pi_{Si} \pi_{Ti}$$

Where  $\lambda_{Gi}$  – Generic steady – state failure rate for device  $i$

$\pi_{Qi}$  – Quality factor for device  $i$

$\pi_{Si}$  – Stress factor for device  $i$

$\pi_{Ti}$  – Temperature factor for device  $i$

### 2.3 Calculation parameter

Operation temperature - 25°C

Environment - Ground Mobile, Uncontrolled

Operation Stress - 50% (Voltage, Current, Power)

Method - Method I, Case 3

**Note:**

Telcordia:

The Telcordia model is based on the Telcordia document, *Reliability Prediction Procedure for Electronic Equipment*, Technical Reference SR-232. This standard, originally developed by AT&T Bell Lab as the Bellcore model, basically modified the component models in ML-HDBK-217 to better reflect the failure rates that AT&T Bell Lab equipment was experiencing in the field. To support taking into account stress, burn-in laboratory, or field data, this model supports different failure rate calculation methods. Telcordia includes the ability to perform a Parts Count or Parts Stress analysis. Relx supports Telcordia Issues 1 and 2 as well as Bellcore Issues 4, 5 and 6. Telcordia Issue 2, released in September 2006, replaces Telcordia Issue 1, released in May 2001. For more information about the fields in Relx Reliability Studio specific to Telcordia Issue 2, refer to Telcordia Issue 2 Fields.

### 3. PREDICTION RESULT

Item	Failure Rate (FITs)	Predicted MTBF (Hours)
LTE Router RUT950	3662,85	273011,44

**Note:**

1. The result represent the failure rate and MTBF of the product according to Telcordia SR-332, Issue 2, Method I, Case 3 under Ground Mobile, Uncontrolled environment, 50% operation stress.
2. Library components of near equivalent or similar technology and function were substituted when the parts could not be exactly found in the library.

### 4. REVISION HISTORY

Rev. No.	Date	Description
1.0	2016-01-07	First release